

FORM PTO-1449 (MODIFIED)	ATTORNEY DOCKET NO.	SERIAL NO.
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT	SP03-090	10,626,310
APPLICANT: Roger A. Allaire, et al.		
FILING DATE July 24, 2003		GROUP: 3723

REFERENCE DESIGNATION							U.S. PATENT DOCUMENTS
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
DVN	AA	2,332,329	10/19/1943	US			
DVN	AB	2,969,624	01/31/1961	US			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation Yes No
DVN	AL	JP 58217264	12/17/1983	Japan			
DVN	AM	DT 1652060	10/28/1967	Germany			
	AN						
	AO						
	AP						
	AQ						

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)	
AR	
AS	
AT	
AU	
AV	
AW	

EXAMINER: *Greg van Hagen* DATE CONSIDERED: 3-28-2005

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609: draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 (MODIFIED) LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT	ATTORNEY DOCKET NO.	SERIAL NO.
	ADP-170 (SP03-090)	10/626,310
	APPLICANT Roger A. Allaire et al.	
	FILING DATE	GROUP: 3723 TBA

REFERENCE DESIGNATION		U.S. PATENT DOCUMENTS					
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
<i>DVN</i>	AA/	5,975,992	11-02-99	Bruce H. Raeder et al.	451	44	
	AB						
	AC						
	AD						
	AE						
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	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation Yes No
<i>DVN</i>	AL/	1 060 833 A1	12-20-00	Europe			X
	AM						
	AN						
	AO						
	AP						
	AQ						

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)	
	AR
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EXAMINER: *Samy van Nguyen* DATE CONSIDERED: 1-21-2005

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